GENERAL DESCRIPTION

This chapter gives an overview of the 260-pin SO DDR4 Dual-In-Line memory modules product family and describes its main characteristics.

FEATURES

- VDD=VDDQ=1.2V +/- 0.06V
- VPP = 2.5V, –125mV/+250mV
- On-die, internal, adjustable VREFDQ generation
- 1.2V pseudo open-drain I/O
- TC of 0°C to 85°C

– 64ms, 8192-cycle refresh at 0°C to 85°C

- JEDEC standard 78ball FBGA※

Above Picture is for reference only!

- Programmable data strobe preambles
- Data strobe preamble training
- Command/Address latency (CAL)
- Multipurpose register READ and WRITE capability
- Write and read leveling
- Self refresh mode
- Low-power auto self refresh (LPASR)
- Temperature controlled refresh (TCR)
- Fine granularity refresh
- Self refresh abort
- Maximum power saving
- Output driver calibration
- Nominal, park, and dynamic on-die termination (ODT)
- Data bus inversion (DBI) for data bus
- Command/Address (CA) parity
- Databus write cyclic redundancy check (CRC)
- Per-DRAM addressability
- Post package repair (PPR) and soft post package repair (sPPR) modes • JEDEC JESD-79-4 compliant

Information for Compliant Products

Product Type	Compliance Code	Description
IND-ID4N21SP16X	16GB DDR4-2133 15/15/15	1 Ran, Non-ECC
IND-ID4N24SP16X	16GB DDR4-2400 17/17/17	1 Ran, Non-ECC
IND-ID4N26SP16X	16GB DDR4-2666 19/19/19	1 Ran, Non-ECC
IND-ID4N29SP16X	16GB DDR4-2933 21/21/21	1 Ran, Non-ECC
IND-ID4N32SP16X	16GB DDR4-3200 22/22/22	1 Ran, Non-ECC

Pinout

260-Pin DDR4 SODIMM Front								260-Pin DDR4 SODIMM Back							
Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol
1	V_{SS}	67	DQ29	133	A1	199	DM5_n/ DBI5_n	2	V_{SS}	68	V_{SS}	134	EVENT_n, NF	200	DQS5_t
3	DQ5	69	V_{SS}	135	V_{DD}	201	V_{SS}	4	DQ4	70	DQ24	136	V_{DD}	202	V_{SS}
5	V_{SS}	71	DQ25	137	CK0_t	203	DQ46	6	V_{SS}	72	V_{SS}	138	CK1_t/NF	204	DQ47
7	DQ1	73	V_{SS}	139	CK0_c	205	V_{SS}	8	DQ0	74	DQS3_c	140	CK1_c/NF	206	V_{SS}
9	V_{SS}	75	DM3_n/ DBI3_n	141	V_{DD}	207	DQ42	10	V_{SS}	76	DQS3_t	142	V_{DD}	208	DQ43
11	DQS0_c	77	V_{SS}	143	PARITY	209	V_{SS}	12	DM0_n/ DBI0_n	78	V_{SS}	144	A0	210	V_{SS}
13	DQS0_t	79	DQ30	145	BA1	211	DQ52	14	V_{SS}	80	DQ31	146	A10/AP	212	DQ53
15	V_{SS}	81	V_{SS}	147	V_{DD}	213	V_{SS}	16	DQ6	82	V_{SS}	148	V_{DD}	214	V_{SS}
17	DQ7	83	DQ26	149	CS0_n	215	DQ49	18	V_{SS}	84	DQ27	150	BA0	216	DQ48
19	V_{SS}	85	V_{SS}	151	WE_n/ A14	217	V_{SS}	20	DQ2	86	V_{SS}	152	RAS_n/ A16	218	V_{SS}
21	DQ3	87	CB5/NC	153	V_{DD}	219	DQS6_c	22	V_{SS}	88	CB4/NC	154	V_{DD}	220	DM6_n/ DBI6_n
23	V_{SS}	89	V_{SS}	155	ODT0	221	DQS6_t	24	DQ12	90	V_{SS}	156	CAS_n/ A15	222	V_{SS}
25	DQ13	91	CB1/NC	157	CS1_n	223	V_{SS}	26	V_{SS}	92	CB0/NC	158	A13	224	DQ54
27	V_{SS}	93	V_{SS}	159	V_{DD}	225	DQ55	28	DQ8	94	V_{SS}	160	V_{DD}	226	V_{SS}
29	DQ9	95	DQS8_c	161	ODT1	227	V_{SS}	30	V_{SS}	96	DM8_n/ DBI_n/NC	162	C0/ CS2_n/NC	228	DQ50
31	V_{SS}	97	DQS8_t	163	V_{DD}	229	DQ51	32	DQS1_c	98	V_{SS}	164	V_{REFCA}	230	V_{SS}
33	DM1_n/ DBI_n	99	V_{SS}	165	C1,CS3_n, NC	231	V_{SS}	34	DQS1_t	100	CB6/NC	166	SA2	232	DQ60
35	V_{SS}	101	CB2/NC	167	V_{SS}	233	DQ61	36	V_{SS}	102	V_{SS}	168	V_{SS}	234	V_{SS}
37	DQ15	103	V_{SS}	169	DQ37	235	V_{SS}	38	DQ14	104	CB7/NC	170	DQ36	236	DQ57
39	V_{SS}	105	CB3/NC	171	V_{SS}	237	DQ56	40	V_{SS}	106	V_{SS}	172	V_{SS}	238	V_{SS}
41	DQ10	107	V_{SS}	173	DQ33	239	V_{SS}	42	DQ11	108	RESET_n	174	DQ32	240	DQS7_c
43	V_{SS}	109	CKE0	175	V_{SS}	241	DM7_n/ DBI7_n	44	V_{SS}	110	CKE1	176	V_{SS}	242	DQS7_t
45	DQ21	111	V_{DD}	177	DQS4_c	243	V_{SS}	46	DQ20	112	V_{DD}	178	DM4_n/ DBI4_n	244	V_{SS}
47	V_{SS}	113	BG1	179	DQS4_t	245	DQ62	48	V_{SS}	114	ACT_n	180	V_{SS}	246	DQ63
49	DQ17	115	BG0	181	V_{SS}	247	V_{SS}	50	DQ16	116	ALERT_n	182	DQ39	248	V_{SS}
51	V_{SS}	117	V_{DD}	183	DQ38	249	DQ58	52	V_{SS}	118	V_{DD}	184	V_{SS}	250	DQ59
53	DQS2_c	119	A12	185	V_{SS}	251	V_{SS}	54	DM2_n/ DBI2_n	120	A11	186	DQ35	252	V_{SS}
55	DQS2_t	121	A9	187	DQ34	253	SCL	56	V_{SS}	122	A7	188	V_{SS}	254	SDA
57	V_{SS}	123	V_{DD}	189	V_{SS}	255	V_{DDSPS}	58	DQ22	124	V_{DD}	190	DQ45	256	SA0
59	DQ23	125	A8	191	DQ44	257	V_{pp}	60	V_{SS}	126	A5	192	V_{SS}	258	V_{TT}
61	V_{SS}	127	A6	193	V_{SS}	259	V_{pp}	62	DQ18	128	A4	194	DQ41	260	SA1
63	DQ19	129	V_{DD}	195	DQ40	—	—	64	V_{SS}	130	V_{DD}	196	V_{SS}	—	—
65	V_{SS}	131	A3	197	V_{SS}	—	—	66	DQ28	132	A2	198	DQS5_c	—	—

Pin Descriptions

Pin Name	Description	Pin Name	Description
A0-A17[1]	SDRAM address bus	SCL	I^2C serial bus clock for SPD-TSE
BA0, BA1	SDRAM bank select	SDA	I^2C serial bus line for SPD-TSE
BG0, BG1	SDRAM bank group select	SA0-SA2	I^2C slave address select for SPD-TSE
RAS_n[2]	SDRAM row address strobe	PARITY	SDRAM parity input
CAS_n[3]	SDRAM column address strobe	VDD	SDRAM I/OO and core power supply
WE_n[4]	SDRAM write enable	C0, C1, C2	Chip ID lines
CS0_n, CS1_n,	DIMM Rank Select Lines	12V	Optional power Supply on socket but not used on UDIMM
CKE0, CEK1	SDRAM clock enable lines input	VREFCA	SDRAM command/address reference supply
ODT0, ODT1	SDRAM on-die termination control lines input	VSS	Power supply return (ground)
ACT_n	SDRAM activate	VDDSPD	Serial SPD-TSE positive power supply
DQ0-DQ63	DIMM memory data bus	ALERT_n	SDRAM ALERT_n output
CB0-CB7	DIMM ECC check bits	VPP	SDRAM Supply
TDQS0_t-TDQS8_t TDQS0_c-TDQS8_c	Dummy loads for mixed populations of x4 based and x8 based RDIMMs. Not used on UDIMMs.		
DQS0_t-DQS8_t	SDRAM data strobes (positive line of differential pair)		
DQS0_c-DQS8_c	SDRAM data strobes (negative line of differential pair)	RESET_n	Set DRAMs to a Known State
DM0_n-DM8_n, DBI0_n-DBI8_n	SDRAM data masks/data bus inersion (x8-based x72 DIMMs)	EVENT_n	SPD signals a thermal event has occurred
CK0_t, CK1_t	SDRAM clock (positive line of differen-tial pair)	VTT	SDRAM I/O termination supply
CK0_c, CK1_c	SDRAM clock (positive line of differen-tial pair)	RFU	Reserved for future use

1. Address A17 is not valid for x8 and x16 based SDRAMs. For UDIMMs, this connection pin is NC.
2. RAS_n is a multiplexed function with A16.
3. CAS_n is a multiplexed function with A15.
4. WE_n is a multiplexed function with A14.

Operating Temperature Range

Symbol	Parameter	Rating	Units	Notes
T_{OPR}	Normal Operating Temperature Range	0 ~ 85	°C	1,2
	Extended Temperature Range (Optional)	85 ~ 95	°C	1,3

Notes 1. Operating Temperature T_{OPER} is the case surface temperature on the center / top side of the DRAM. For measurement conditions, please refer to the JEDEC document JESD51-2.

Notes 2. The Normal Temperature Range specifies the temperatures where all DRAM specifications will be supported. During operation, the DRAM case temperature must be maintained between 0 to 85 °C under all operating conditions.

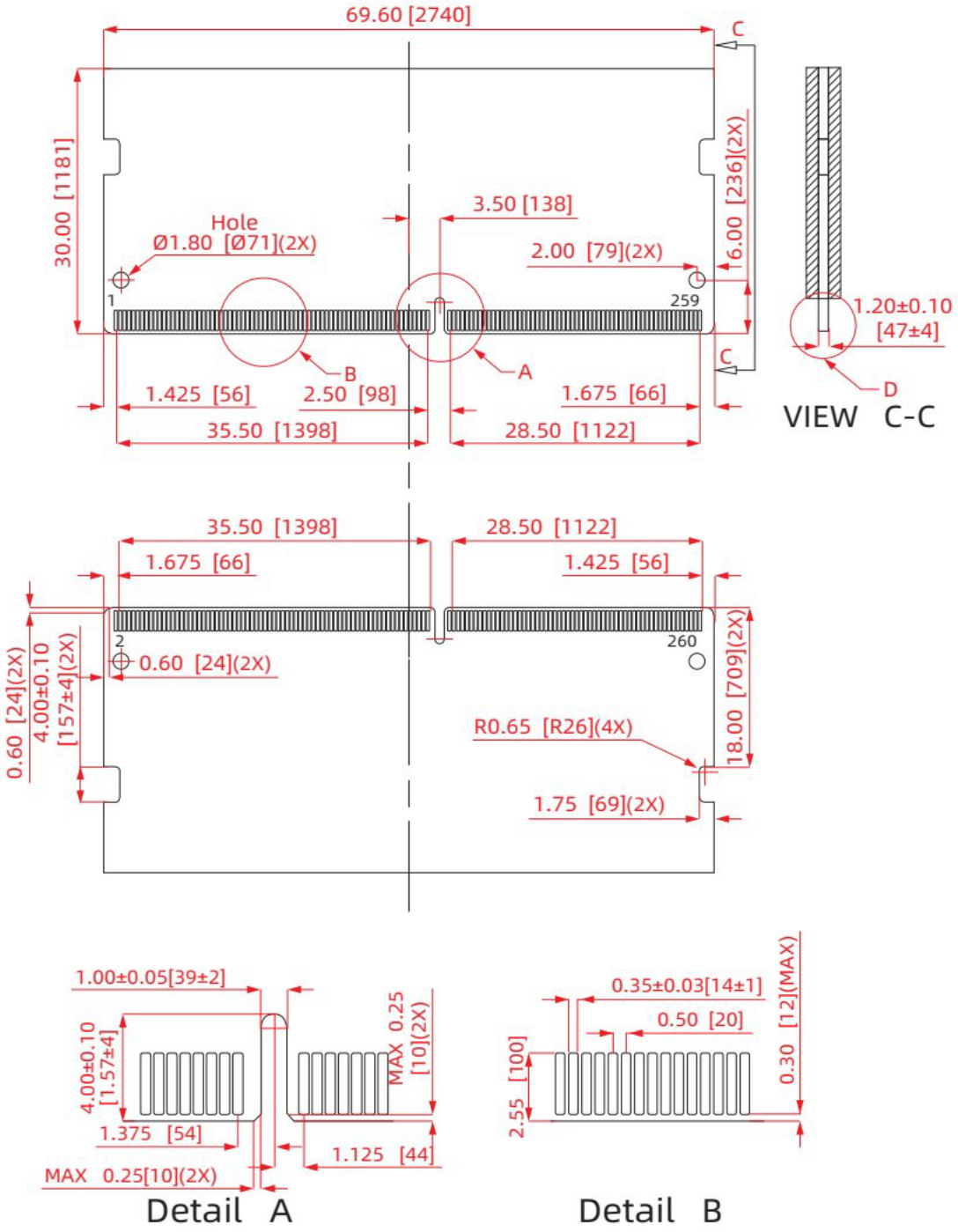
Notes 3. Some applications require operation of the DRAM in the Extended Temperature Range between 85 °C and 95 °C case temperature. Full specifications are supported in this range, but the following additional conditions apply:

a. Refresh commands must be doubled in frequency, therefore reducing the Refresh interval t_{REFI} to 3.9 µs. It is also possible to specify a component with 1X refresh (t_{REFI} to 7.8µs) in the Extended Temperature Range. Please refer to DIMM SPD for option availability.

b. If Self-Refresh operation is required in the Extended Temperature Range, then it is mandatory to either use the Manual Self-Refresh mode with Extended Temperature Range capability (MR2 A6 = 0b and MR2 A7 = 1b) or enable the optional Auto Self-Refresh mode (MR2 A6 = 1b and MR2 A7 = 0b).

Follow JEDEC specification.

Physical Dimensions



Note:
All dimensions are in millimeters[mils] and should be
kept wihtin a tolerance of ±0.15[6], unless otherwise specified.

※Above Picture is for reference only!

Units: Millimeters